## JJMICROELECTRONICS

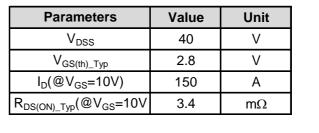
# 40V, 150A, 3.4mΩ N-channel Power Trench MOSFET JMTC035N04A

#### Features

- Excellent  $\mathsf{R}_{\mathsf{DS}(\mathsf{ON})}$  and Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

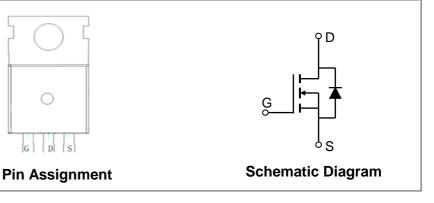
#### Applications

- Load Switch
- PWM Application
- Power Management





**Product Summary** 



#### **Ordering Information**

TO-220-3L Top View

Device	Marking	MSL	Form	Package	Tube(pcs)	Per Carton (pcs)
JMTC035N04A	JMTC035N04A	N/A	Tube	TO-220-3L	50	5000

#### Absolute Maximum Ratings (@ $T_C = 25^{\circ}C$ unless otherwise specified)

Symbol	Parameter		Value	Unit
V <sub>DS</sub>	Drain-to-Source Voltage	Drain-to-Source Voltage		V
V <sub>GS</sub>			±20	V
	Continuous Droin Current		150	А
Ι <sub>D</sub>	Continuous Drain Current	$T_{\rm C} = 100^{\circ}{\rm C}$	106	~
I <sub>DM</sub>	Pulsed Drain Current <sup>(1)</sup>	Pulsed Drain Current <sup>(1)</sup>		А
E <sub>AS</sub>	Single Pulsed Avalanche Energy	Single Pulsed Avalanche Energy <sup>(2)</sup>		mJ
P <sub>D</sub>	Dower Dissinction	$T_{\rm C} = 25^{\circ}{\rm C}$	216	w
		$T_{\rm C} = 100^{\circ}{\rm C}$	87	vv
T <sub>J</sub> , T <sub>STG</sub>	Junction & Storage Temperature R	Junction & Storage Temperature Range		°C

#### **Thermal Characteristics**

Symbol	Parameter	Мах	Unit
$R_{\thetaJA}$	Thermal Resistance, Junction to Ambient <sup>(3)</sup>	75	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction to Case 0.6		C/VV

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics			1		<u>.</u>
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$	40	-	-	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 40V, V_{GS} = 0V$	-	-	1.0	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					-
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$	2.0	2.8	4.0	V
R <sub>DS(ON)</sub>	Static Drain-Source ON-Resistance <sup>(4)</sup>	$V_{GS} = 10V, I_D = 30A$	-	3.4	4.0	mΩ
Dynami	ic Characteristics					
$R_g$	Gate Resistance	f = 1MHz	-	1.7	-	Ω
C <sub>iss</sub>	Input Capacitance		3517	4924	6647	pF
C <sub>oss</sub>	Output Capacitance	$V_{GS} = 0V, V_{DS} = 20V,$ f = 1MHz	361	505	682	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		194	272	367	pF
Qg	Total Gate Charge		52	73	99	nC
Q <sub>gs</sub>	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 20V, I_D = 30A$	20	27	37	nC
$Q_{gd}$	Gate Drain("Miller") Charge	VDS = 200, 10 = 00, 1	10	15	20	nC
Switchi	ing Characteristics					
t <sub>d(on)</sub>	Turn-On DelayTime		-	17	-	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 20V$	-	27	-	ns
t <sub>d(off)</sub>	Turn-Off DelayTime	$I_D = 30A, R_{GEN} = 3\Omega$	-	39	-	ns
t <sub>f</sub>	Turn-Off Fall Time		-	11	-	ns
Body D	iode Characteristics	•		•	•	•
I <sub>S</sub>	Maximum Continuous Body Diode Forward	Current	-	-	150	А
I <sub>SM</sub>	Maximum Pulsed Body Diode Forward Current		-	-	600	А
$V_{SD}$	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 30A$	-		1.2	V
trr	Body Diode Reverse Recovery Time		18	25	33	ns
Qrr	Body Diode Reverse Recovery Charge	− I <sub>F</sub> = 30A, di/dt = 100A/us	-	17	-	nC

#### **Electrical Characteristics** ( $T_J = 25^{\circ}C$ unless otherwise specified)

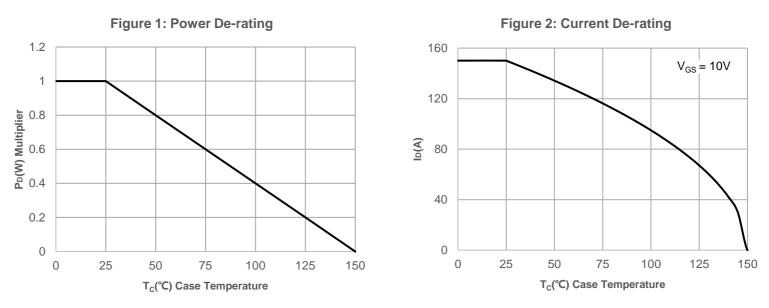
Notes: 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.

2.  $E_{AS}$  condition: Starting  $T_J$ =25C,  $V_{DD}$ =20V,  $V_G$ =10V,  $R_G$ =25ohm, L=0.5mH,  $I_{AS}$ =35.7A,  $V_{DD}$ =0V during time in avalanche.

3.  $R_{\theta JA}$  is measured with the device mounted on a 1inch  $^2$  pad of 2oz copper FR4 PCB.

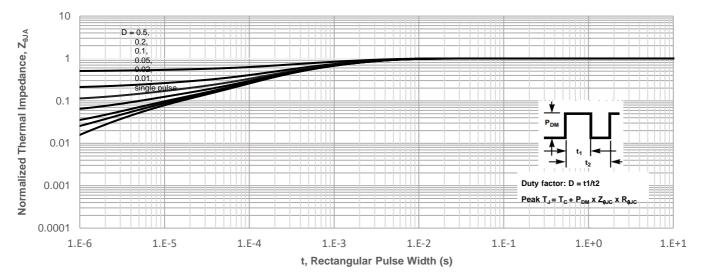
4. Pulse Test: Pulse Width  ${\leqslant}300\mu\text{s},$  Duty Cycle  ${\leqslant}0.5\%.$ 



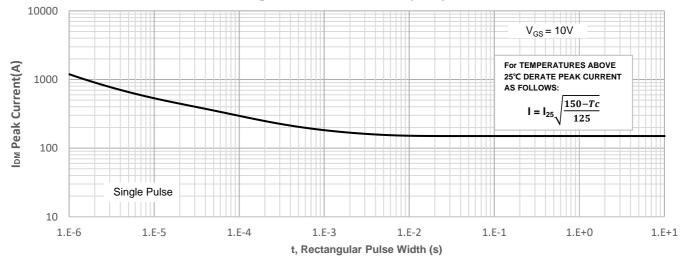


## **Typical Performance Characteristics**







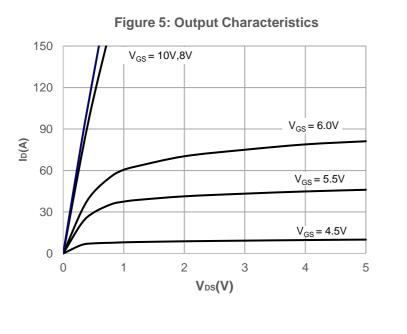




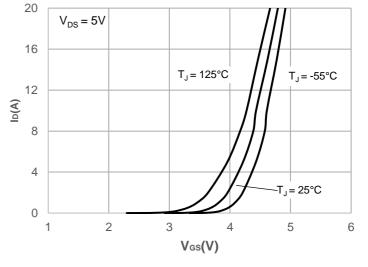
T<sub>J</sub>= -55°C

1

1.2



## **Typical Performance Characteristics**



**Figure 8: Body Diode Characteristics** 

\_= 25°C

100

10

1

0.1

0.01

0

0.2

Is(A)

 $V_{GS} = 0V$ 

T<sub>J</sub> = 125°C

0.4

**Figure 6: Typical Transfer Characteristics** 

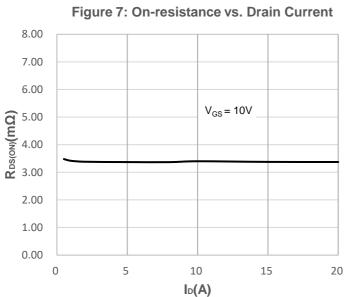
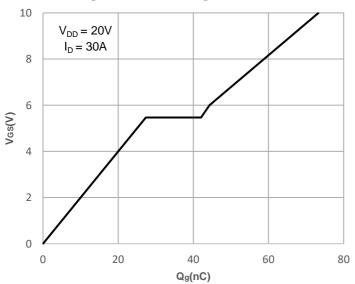


Figure 9: Gate Charge Characteristics

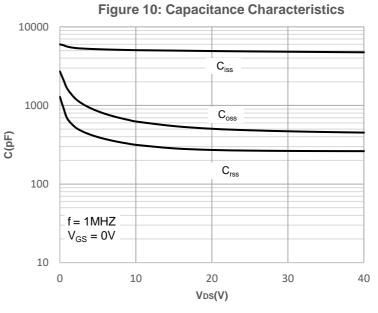


auro 10. Consoltanos Characteristico

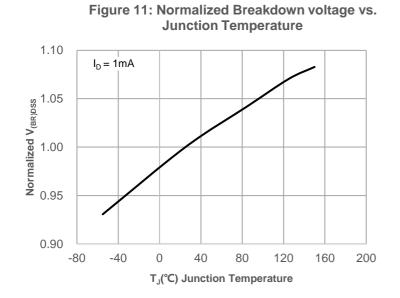
0.8

0.6

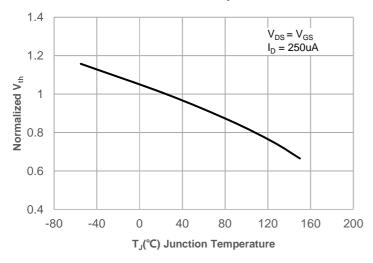
Vsd(V)

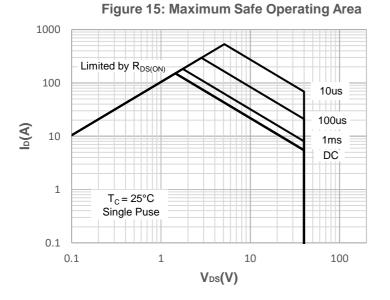




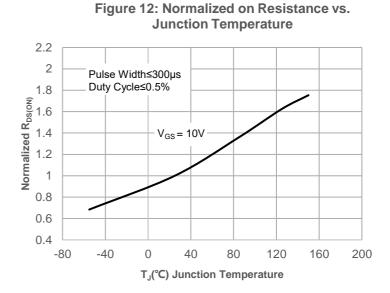


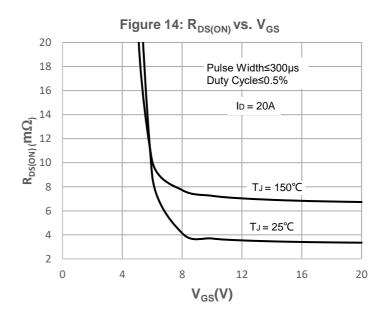














## **Test Circuit**

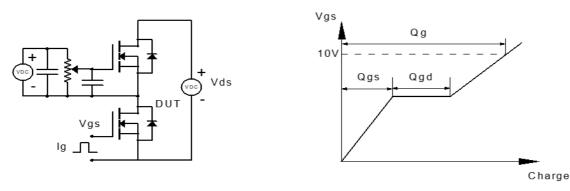


Figure 1: Gate Charge Test Circuit & Waveform

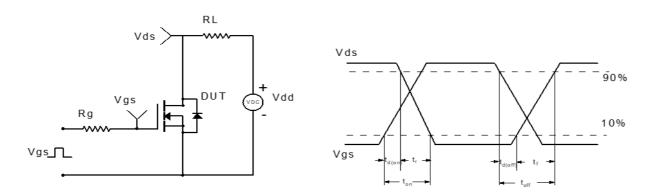


Figure 2: Resistive Switching Test Circuit & Waveform

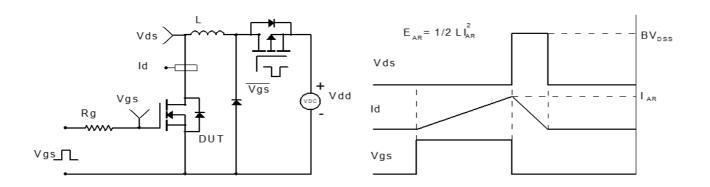


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

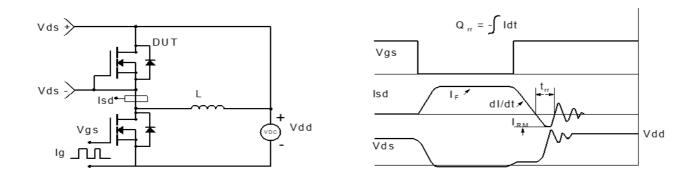
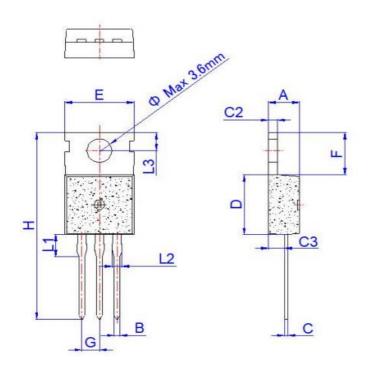


Figure 4: Diode Recovery Test Circuit & Waveform



## Package Mechanical Data(TO-220-3L)



Ref.			Dime	ensions			
	Millimeters			Inches			
	Min.	Тур.	Max.	Min.	Тур.	Max.	
A	4.40		4.60	0.173		0.181	
В	0.70		0.90	0.028		0.035	
С	0.45		0.60	0.018		0.024	
C2	1.23		1.32	0.048		0.052	
C3	2.20		2.60	0.087		0.102	
D	8.90		9.90	0.350		0.390	
E	9.90		10.3	0.390		0.406	
F	6.30		6.90	0.248		0.272	
G		2.54			0.1		
Н	28.0		29.8	1.102		1.173	
L1		3.39			0.133		
L2	1.14		1.70	0.045		0.067	
L3	2.65		2.95	0.104		0.116	
Φ		3.6			0.142		

Information furnished in this document is believed to be accurate and reliable. However, Jiangsu JieJie Microelectronics Co.,Ltd assumes no responsibility for the consequences of use without consideration for such information nor use beyond it. Information mentioned in this document is subject to change without notice, apart from that when an agreement is signed, Jiangsu JieJie complies with the agreement. Products and information provided in this document have no infringement of patents. Jiangsu JieJie assumes no responsibility for any infringement of other rights of third parties which may result from the use of such products and information.

**J** is a registered trademark of Jiangsu JieJie Microelectronics Co.,Ltd.

